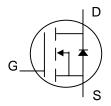


N-CHANNEL ENHANCEMENT-MODE POWER MOSFET

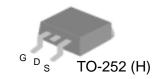
Dynamic dv/dt rating
Repetitive-avalanche rated
Fast switching
Simple drive requirement

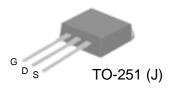


 BV_{DSS} 600V $R_{DS(ON)}$ 8Ω 1.6A

Description

The SSM01N60H is supplied in the industry-standard TO-252 package, which is widely preferred for commercial and industrial surface mount applications, and is well suited for AC/DC converters. The through-hole version (SSM01N60J) is available for low-footprint applications.





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	600	V
V_{GS}	Gate-Source Voltage	± 30	٧
I _D @ T _C =25°C	Continuous Drain Current, V _{GS} @ 10V	1.6	А
I _D @ T _C =100°C	Continuous Drain Current, V _{GS} @ 10V	1	А
I _{DM}	Pulsed Drain Current ¹	6	Α
P _D @ T _C =25°C	Total Power Dissipation	39	W
	Linear Derating Factor	0.31	W/°C
E _{AS}	Single Pulse Avalanche Energy ²	13	mJ
I _{AR}	Avalanche Current	1.6	А
E _{AR}	Repetitive Avalanche Energy	0.5	mJ
T _{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter		Value	Unit
Rthj-c	Thermal Resistance Junction-case	Max.	3.2	°C/W
Rthj-a	Thermal Resistance Junction-ambient	Max.	110	°C/W



Electrical Characteristics @ T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V, I_D =250uA	600	-	-	V
Δ BV _{DSS} / Δ T _j	Breakdown Voltage Temperature Coefficient	Reference to 25°C, ID=1mA	-	0.6	-	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =0.8A	-	7.2	8	Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250uA$	2	-	4	٧
9 _{fs}	Forward Transconductance	V_{DS} =10V, I_{D} =0.8A	-	0.8	-	S
I _{DSS}	Drain-Source Leakage Current (T _j =25°C)	V _{DS} =600V, V _{GS} =0V	-	-	10	uA
	Drain-Source Leakage Current (T _j =150°C)	V _{DS} =480V, V _{GS} =0V	-	-	100	uA
I _{GSS}	Gate-Source Leakage	$V_{GS} = \pm 30V$	-	-	±100	nA
Q_g	Total Gate Charge ³	I _D =1.6A	-	7.7	-	nC
Q_{gs}	Gate-Source Charge	V _{DS} =480V	-	1.5	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	V _{GS} =10V	-	2.6	-	nC
t _{d(on)}	Turn-on Delay Time ³	V _{DD} =300V	-	8	-	ns
t _r	Rise Time	I _D =1.6A	-	5	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=10\Omega, V_{GS}=10V$	-	14	-	ns
t _f	Fall Time	$R_D=187.5\Omega$	-	7	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	286	-	pF
C _{oss}	Output Capacitance	V _{DS} =25V	-	25	_	рF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	6	-	pF

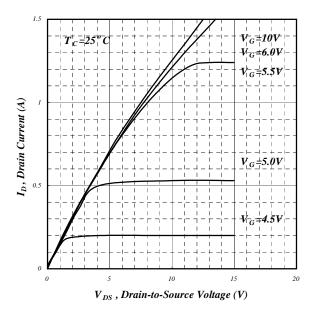
Source-Drain Diode

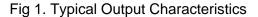
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
I _S	Continuous Source Current (Body Diode)	$V_D = V_G = 0V$, $V_S = 1.5V$	ı	1	1.6	Α
I _{SM}	Pulsed Source Current (Body Diode) ¹		-	-	6	Α
V_{SD}	Forward On Voltage ³	T _j =25°C, I _S =1.6A, V _{GS} =0V	-	-	1.5	V

Notes:

- 1. Pulse width limited by safe operating area.
- 2.Starting $\rm T_{j}\!\!=\!\!25^{o}C$, $\rm V_{DD}\!\!=\!\!50V$, $\rm L\!\!=\!\!10mH$, $\rm R_{G}\!\!=\!\!25\Omega$, $\rm I_{AS}\!\!=\!\!1.6A.$
- 3. Pulse width <300us, duty cycle <2%.







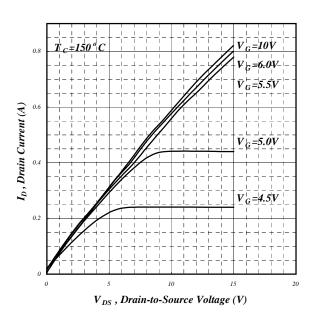


Fig 2. Typical Output Characteristics

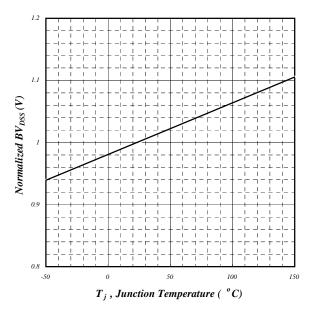


Fig 3. Normalized $\mathrm{BV}_{\mathrm{DSS}}\,$ vs. Junction Temperature

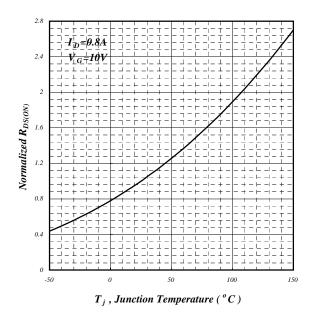


Fig 4. Normalized On-Resistance vs. Junction Temperature



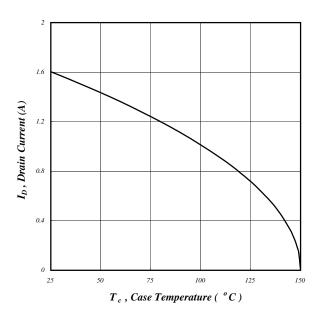


Fig 5. Maximum Drain Current vs.

Case Temperature

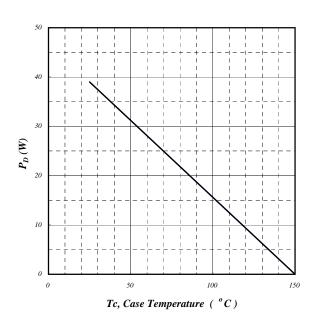


Fig 6. Typical Power Dissipation

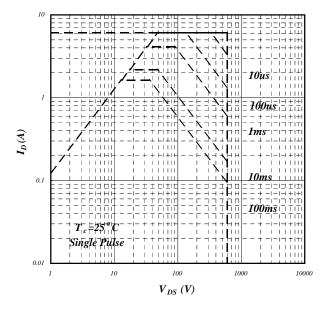


Fig 7. Maximum Safe Operating Area

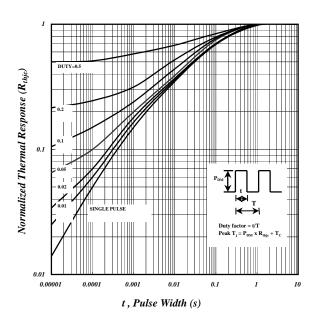
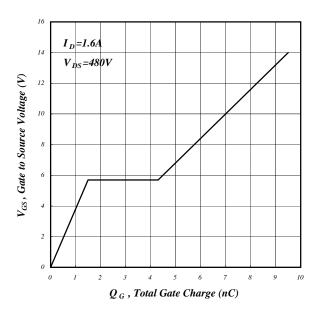


Fig 8. Effective Transient Thermal Impedance





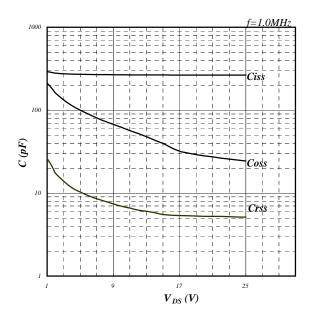
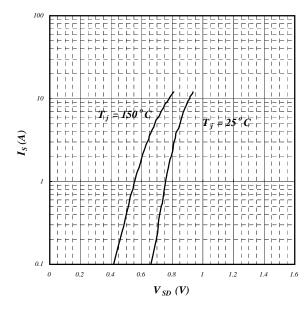
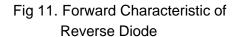


Fig 9. Gate Charge Characteristics

Fig 10. Typical Capacitance Characteristics





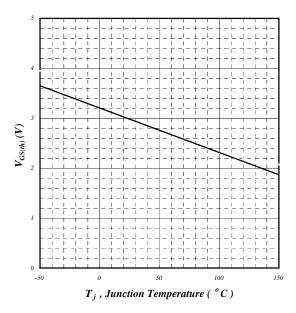
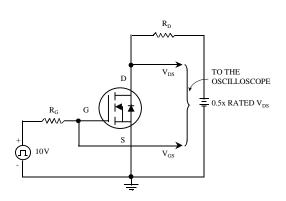


Fig 12. Gate Threshold Voltage vs. Junction Temperature





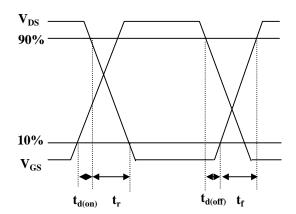
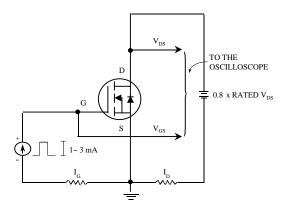


Fig 13. Switching Time Circuit

Fig 14. Switching Time Waveform



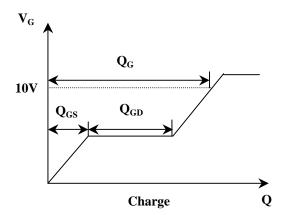


Fig 15. Gate Charge Circuit

Fig 16. Gate Charge Waveform

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